

**Search Notes**

Application/Control No.

10/717,562

Examiner

Joseph Nguyen

Applicant(s)/Patent under  
Reexamination

ISHIKAWA ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	72, 59	5/2/2006	JN
257	20, 258	5/2/2006	JN
257	e51.055	5/2/2006	JN
438	48, 128	5/2/2006	JN
438	149,151	5/2/2006	JN
438	157,283	5/2/2006	JN
349	38,39	5/31/06	JN
349	151	6/13/06	JN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	72, 59	5/2/2006	JN
257	E51.055	5/2/2006	JN
257	258	5/2/2006	JN
438/48,128,149,151,157, 283		5/2/2006	JN
349/38,39		5/31/06	JN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search history in EAST	5/2/2006	JN